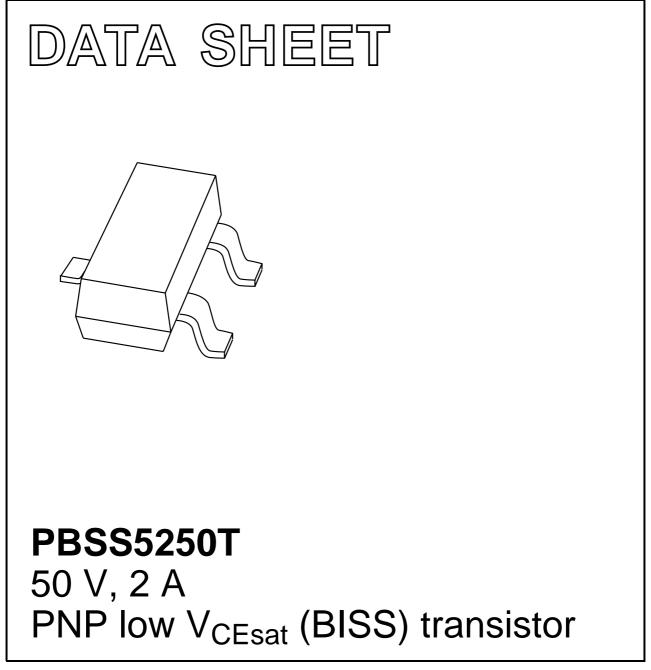
DISCRETE SEMICONDUCTORS



Product data sheet

2003 Oct 09



PBSS5250T

NXP Semiconductors

50 V, 2 A PNP low V_{CEsat} (BISS) transistor

FEATURES

- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability: I_C and I_{CM}
- Higher efficiency leading to less heat generation
- Reduced printed-circuit board requirements
- Cost effective alternative to MOSFETs in specific applications.

APPLICATIONS

- Power management
 - DC/DC converters
 - Supply line switching
 - Battery charger
 - LCD backlighting
- Peripheral drivers
 - Driver in low supply voltage applications (e.g. lamps and LEDs)
 - Inductive load driver (e.g. relays, buzzers and motors).

DESCRIPTION

PNP BISS transistor in a SOT23 plastic package offering ultra low V_{CEsat} and R_{CEsat} parameters.

MARKING

TYPE NUMBER	MARKING CODE ⁽¹⁾
PBSS5250T	3H*

Note

- 1. * = p: Made in Hong Kong.
 - * = t: Made in Malaysia.

* = W: Made in China.

ORDERING INFORMATION

TYPE NUMBER		PACKAGE		
	NAME	NAME DESCRIPTION VERSION		
PBSS5250T	_	plastic surface mounted package; 3 leads SOT2		

QUICK REFERENCE DATA

SYMBOL	PARAMETER	MAX.	UNIT
V _{CEO}	collector-emitter voltage	-50	V
I _C	collector current (DC) -2		А
I _{CM}	peak collector current -3		А
R _{CEsat}	equivalent on-resistance 150		mΩ

PINNING

PIN	DESCRIPTION	
1	base	
2	emitter	
3	collector	

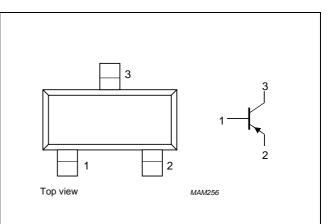


Fig.1 Simplified outline (SOT23) and symbol.

50 V, 2 A PNP low V_{CEsat} (BISS) transistor

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CBO}	collector-base voltage	open emitter	-	-50	V
V _{CEO}	collector-emitter voltage	open base	-	-50	V
V _{EBO}	emitter-base voltage	open collector	-	-5	V
I _C	collector current (DC)		-	-2	А
I _{CM}	peak collector current	single peak	-	-3	А
I _B	base current (DC)		-	-300	mA
P _{tot}	total power dissipation	$T_{amb} \le 25 \ ^{\circ}C; note 1$		300	mW
		$T_{amb} \le 25 \ ^{\circ}C$; note 2	-	480	mW
Tj	junction temperature		-	150	°C
T _{amb}	operating ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C

Notes

- 1. Device mounted on a FR4 printed-circuit board; single-sided copper; tinplated; standard footprint.
- 2. Device mounted on a FR4 printed-circuit board; single-sided copper; tinplated; mounting pad for collector 1 cm².

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient	in free air; note 1	417	K/W
		in free air; note 2	260	K/W

Notes

- 1. Device mounted on a FR4 printed-circuit board; single-sided copper; tinplated; standard footprint.
- 2. Device mounted on a FR4 printed-circuit board; single-sided copper; tinplated; mounting pad for collector 1 cm².

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CHARACTERISTICS

 T_j = 25 °C; unless otherwise specified.

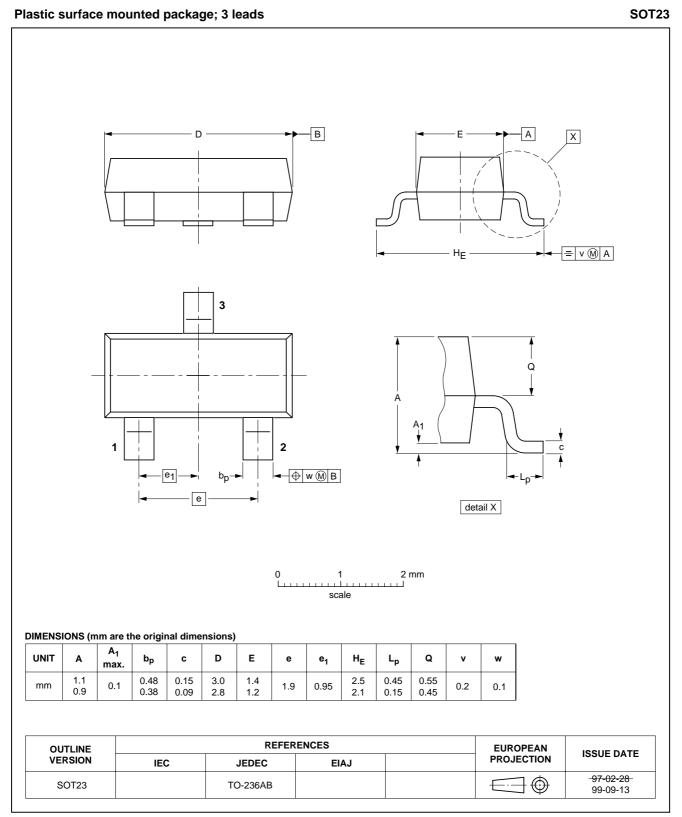
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{CBO}	collector cut-off current	$V_{CB} = -50 \text{ V}; \text{ I}_{E} = 0$	-	-	-100	nA
		$V_{CB} = -50 \text{ V}; I_E = 0; T_j = 150 \text{ °C}$	-	-	-50	μA
I _{EBO}	emitter cut-off current	$V_{EB} = -5 \text{ V}; \text{ I}_{C} = 0$	-	-	-100	nA
h _{FE}	DC current gain	$V_{CE} = -2 \text{ V}; \text{ I}_{C} = 0.5 \text{ A}$	200	-	-	
		$V_{CE} = -2 \text{ V}; I_{C} = 1 \text{ A}; \text{ note } 1$	200	-	-	
		$V_{CE} = -2 \text{ V}; I_{C} = 2 \text{ A}; \text{ note } 1$	130	_	_	
V _{CEsat}	collector-emitter saturation	$I_{\rm C} = -0.5$ A; $I_{\rm B} = -50$ mA	-	-	-90	mV
	voltage	$I_{\rm C} = -1$ A; $I_{\rm B} = -50$ mA	-	-	-180	mV
		$I_{\rm C} = -2$ A; $I_{\rm B} = -100$ mA	-	-	-300	mV
R _{CEsat}	equivalent on-resistance	$I_{\rm C} = -2$ A; $I_{\rm B} = -200$ mA; note 1	-	-	150	mΩ
V _{BEsat}	base-emitter saturation voltage	$I_{\rm C} = -2$ A; $I_{\rm B} = -100$ mA; note 1	_	_	-1.1	V
V _{BEon}	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; I_{C} = -1 \text{ A}; \text{ note } 1$	-1.2	-	-	V
f _T	transition frequency	$I_{C} = -100 \text{ mA}; V_{CE} = -5 \text{ V};$ f = 100 MHz	100	-	-	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = I_e = 0; f = 1 \text{ MHz}$	-	-	35	pF

Note

1. Pulse test: $t_p \leq 300~\mu s;~\delta \leq 0.02.$

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PACKAGE OUTLINE



50 V, 2 A PNP low V_{CEsat} (BISS) transistor

PBSS5250T

DATA SHEET STATUS

DOCUMENT STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

Notes

- 1. Please consult the most recently issued document before initiating or completing a design.
- The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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NXP Semiconductors

Customer notification

This data sheet was changed to reflect the new company name NXP Semiconductors. No changes were made to the content, except for the legal definitions and disclaimers.

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Printed in The Netherlands

R75/01/pp7

Date of release: 2003 Oct 09

Document order number: 9397 750 11904

